


<b>Search Notes</b> 	<b>Application/Control No.</b> 10737281	<b>Applicant(s)/Patent Under Reexamination</b> WEI ET AL.
	<b>Examiner</b> Pham, Michael D	<b>Art Unit</b> 2167

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
707/204, 200	11/19/2009	MP
Assignee Search	11/19/2009	MP
Inventor Search	11/19/2009	MP
East Search (keywords)	11/19/2009	MP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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